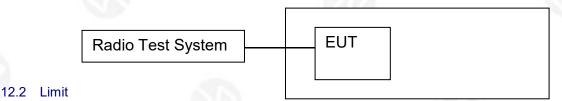


### **FREQUENCY STABILITY**

# 12.1 Block Diagram Of Test Setup



Manufacturers of U-NII devices are responsible for ensuring frequency stability such that an emission is maintained within the band of operation under all conditions of normal operation as specified in the user's manual.

### 12.3 Test procedure

- 1. The EUT was placed inside temperature chamber and powered and powered by nominal DC voltage.
- 2. Set EUT as normal operation.
- 3. Turn the EUT on and couple its output to spectrum.
- 4. Turn the EUT off and set the chamber to the highest temperature specified.
- 5. Allow sufficient time (approximately 30 min) for the temperature of the chamber to stabilize, turn the EUT and measure the operating frequency.
- 6. Repeat step with the temperature chamber set to the lowest temperature.

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### 12.4 Test Result

TX Frequency (5150-5250MHz) ANT1

Voltage vs. Frequency Stability

- 1	3/2	-	Reference Frequency: 5180MHz				
TEST CONDITIONS			f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
T nom		V nom (V) 120	5180.0925	5180	0.0925	17.8636	
(°C)	20	V max (V) 132	5180.0444	5180	0.0444	8.5624	
		V min (V) 108	5180.1174	5180	0.1174	22.6697	
Limits			±20ppm				
	R	esult	Complies				

# Temperature vs. Frequency Stability

	Temperature vs. Trequency Stability										
				Refer	ence Fred	quency: 5	180MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)				
		T (°C)	0	5180.0133	5180	0.0133	2.5630				
V nom		T (°C)	10	5180.0457	5180	0.0457	8.8263				
(V)	120	T (°C)	20	5180.0016	5180	0.0016	0.3111				
( V )		T (°C)	30	5180.0520	5180	0.0520	10.0304				
		T (°C)	40	5180.0268	5180	0.0268	5.1654				
	Limits			±20ppm							
	Re	sult		Complies							

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				Reference Frequency: 5200MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
Tnom	10	V nom (V)	120	5200.0452	5200	0.0452	8.7004	
T nom ( (°C)	20	V max (V)	132	5200.0223	5200	0.0223	4.2802	
( 0)		V min (V)	108	5200.0062	5200	0.0062	1.2002	
Limits				±20ppm				
	Re	esult	b))	Complies				

# Temperature vs. Frequency Stability

romporator	smperature vs. Frequency Stability									
				Refer	Reference Frequency: 5200MHz					
Т	TEST CONDITIONS				fc	Max. Deviation (MHz)	Max. Deviation (ppm)			
		T (°C)	0	5200.0019	5200	0.0019	0.3623			
V nom		T (°C)	10	5200.0210	5200	0.0210	4.0331			
	120	T (°C)	20	5200.0354	5200	0.0354	6.8005			
(V)		T (°C)	30	5200.0120	5200	0.0120	2.3122			
		T (°C)	40	5200.0045	5200	0.0045	0.8656			
	Limits			±20ppm						
	Re	sult	37	Complies						













	_			Reference Frequency: 5240MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
T nom	10	V nom (V)	120	5240.0317	5240	0.0317	6.0541	
(°C)	20	V max (V)	132	5240.0323	5240	0.0323	6.1672	
( C)		V min (V)	108	5240.0216	5240	0.0216	4.1284	
Limits				±20ppm				
	R	esult	20	Complies				

1 cmpc1 a car c	smperature vs. Frequency Stability										
				Refer	ence Fred	quency: 52	240MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)				
		T (°C)	0	5240.0497	5240	0.0497	9.4788				
V nom		T (°C)	10	5240.0327	5240	0.0327	6.2400				
	120	T (°C)	20	5240.0138	5240	0.0138	2.6372				
(V)		T (°C)	30	5240.0515	5240	0.0515	9.8369				
		T (°C)	40	5240.0326	5240	0.0326	6.2242				
	Limits			±20ppm							
	Re	sult	4	Complies							













TX Frequency (5250-5350MHz) Voltage vs. Frequency Stability

	Reference Frequency: 5260MHz				
TEST CONDITIONS f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)		
T nom	5260	0.0079	1.4963		
(°C) 20 V max (V) 132 5260.0307	5260	0.0307	5.8294		
V min (V) 108   5260.0246	5260	0.0246	4.6700		
Limits	±20ppm				
Result	Complies				

	60			Refer	ence Fred	quency: 5	260MHz
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
		T (°C)	0	5260.0209	5260	0.0209	3.9758
V nom		T (°C)	10	5260.0000	5260	0.0000	0.0016
(V)	120	T (°C)	20	5260.0088	5260	0.0088	1.6788
( v )		T (°C)	30	5260.0503	5260	0.0503	9.5678
		T (°C)	40	5260.0888	5260	0.0888	16.8774
	Limits			±20ppm			
	Re	sult		Complies			











	_			Reference Frequency: 5280MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
T nom	10	V nom (V)	120	5280.0193	5280	0.0193	3.6494	
(°C)	20	V max (V)	132	5280.0422	5280	0.0422	7.9836	
( )		V min (V)	108	5280.0449	5280	0.0449	8.5120	
Limits				±20ppm				
	Re	esult	20	Complies				

Temperature vs. Frequency Stability

	emperature vs. Trequency Stability										
				Refer	ence Fred	quency: 52	280MHz				
Т	TEST CONDITIONS				fc	Max. Deviation (MHz)	Max. Deviation (ppm)				
		T (°C)	0	5280.0878	5280	0.0878	16.6307				
V nom		T (°C)	10	5280.0176	5280	0.0176	3.3308				
	120	T (°C)	20	5280.0270	5280	0.0270	5.1060				
(V)		T (°C)	30	5280.0812	5280	0.0812	15.3764				
		T (°C)	40	5280.0581	5280	0.0581	10.9960				
	Limits			±20ppm							
	Re	sult	37	Complies							













				Reference Frequency: 5320MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
Tnom	10	V nom (V)	120	5320.0862	5320	0.0862	16.2032	
T nom (°C)	20	V max (V)	132	5320.0058	5320	0.0058	1.0832	
( 0)		V min (V)	108	5320.0746	5320	0.0746	14.0292	
	Li	mits		±20ppm				
	R	esult	b)	Complies				

mperacare	perature vs. Trequency Stability										
				Refer	rence Fred	quency: 53	320MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)				
		T (°C)	0	5320.0494	5320	0.0494	9.2819				
V nom		T (°C)	10	5320.0153	5320	0.0153	2.8722				
(V)	120	T (°C)	20	5320.0678	5320	0.0678	12.7355				
(V)		T (°C)	30	5320.0697	5320	0.0697	13.0947				
		T (°C)	40	5320.0632	5320	0.0632	11.8830				
	Limits			±20ppm							
	Re	sult	7	Complies							













TX Frequency (5470-5725MHz)
Voltage vs. Frequency Stability

				Reference Frequency: 5500MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
T nom		V nom (V)	120	5550.0390	5500	50.0390	9097.9924	
	20	V max (V) 132		5550.0378	5500	50.0378	9097.7741	
(°C)	V min (V) 108				5500	50.0912	9107.4821	
	Li	mits	2	±20ppm				
	R	esult	1.9	Complies				

	60			Refer	Reference Frequency: 5500MHz				
TI	EST CO	NDITIONS	3	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)		
		T (°C)	0	5500.0327	5500	0.0327	5.9393		
V nom		T (°C)	10	5500.0521	5500	0.0521	9.4696		
(V)	120	T (°C)	20	5500.0759	5500	0.0759	13.8027		
( v )		T (°C)	30	5500.0565	5500	0.0565	10.2677		
T (°C) 40				5500.0827	5500	0.0827	15.0421		
	Limits				±20ppm				
	Re	sult		Complies					











				Reference Frequency: 5580MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
T nom	9	V nom (V)	120	5580.0274	5580	0.0274	4.9019	
(°C)	20	V max (V)	132	5580.0470	5580	0.0470	8.4283	
( )	V min (V) 108				5580	0.0327	5.8627	
0	Li	mits		±20ppm				
	Re	esult	60	Complies				

		•	•	Refer	ence Fred	quency: 5	580MHz	
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
		T (°C)	0	5580.0342	5580	0.0342	6.1317	
V nom		T (°C)	10	5580.0198	5580	0.0198	3.5397	
(V)	120	T (°C)	20	5580.0367	5580	0.0367	6.5794	
( <b>v</b> )		T (°C)	30	5580.0833	5580	0.0833	14.9342	
	T (°C) 40				5580	0.0542	9.7065	
	Limits				±20ppm			
	Re	sult	37	Complies				













				Reference Frequency: 5700MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
T nom	9	V nom (V)	120	5700.0518	5700	0.0518	9.0840	
(°C)	20	V max (V)	132	5700.0183	5700	0.0183	3.2188	
( )	V min (V) 108				5700	0.0128	2.2500	
0	Li	mits		±20ppm				
	Re	esult	D2	Complies				

Temperature vs. Frequency Stability

	vo. Troqu	iency Stabii		Refer	ence Fred	quency: 5	700MHz	
Т	TEST CONDITIONS				fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
		T (°C)	0	5700.0302	5700	0.0302	5.3063	
V nom		T (°C)	10	5700.0117	5700	0.0117	2.0540	
(V)	120	T (°C)	20	5700.0012	5700	0.0012	0.2139	
( )		T (°C)	30	5700.0221	5700	0.0221	3.8748	
	T (°C)   40				5700	0.0097	1.6987	
	Limits				±20ppm			
Result				Complies				













TX Frequency (5725-5850MHz) Voltage vs. Frequency Stability

				Reference Frequency: 5745MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
Tnom		V nom (V)	120	5745.0905	5745	0.0905	15.7564	
T nom (°C)	20	V max (V)	132	5745.0000	5745	0.0000	0.0031	
( )		V min (V)	108	5745.0905	5745	0.0905	15.7564	
	Li	mits	2	±20ppm				
	Re	esult	1.9	Complies				

# Temperature vs. Frequency Stability

	60			Refer	Reference Frequency: 5745MHz				
Т	EST CO	NDITIONS	;	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)		
		T (°C)	0	5745.0603	5745	0.0603	10.4992		
V nom		T (°C)	10	5745.0365	5745	0.0365	6.3464		
(V)	120	T (°C)	20	5745.0543	5745	0.0543	9.4598		
( v )		T (°C)	30	5745.0589	5745	0.0589	10.2488		
		T (°C)	40	5745.0802	5745	0.0802	13.9548		
	Lir	nits	7	±20ppm					
	Re	sult		Complies					











	_			Reference Frequency: 5785MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
T nom	9	V nom (V)	120	5785.0077	5785	0.0077	1.3287	
(°C)	20	V max (V)	132	5785.0427	5785	0.0427	7.3815	
( C)		V min (V)	108	5785.0312	5785	0.0312	5.3969	
	Li	mits		±20ppm				
	Re	esult	20	Complies				

Temperature vs. Frequency Stability

Temperature	e vs. ried	quency Stabi	1114				1	
				Reference Frequency: 5785MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
		T (°C)	0	5785.0152	5785	0.0152	2.6224	
V nom		T (°C)	10	5785.0299	5785	0.0299	5.1722	
(V)	120	T (°C) 20		5785.0060	5785	0.0060	1.0346	
(V)		T (°C)	30	5785.0747	5785	0.0747	12.9206	
		T (°C)	40	5785.0447	5785	0.0447	7.7322	
	Lir	nits	2	±20ppm				
	Re	sult	37	Complies				
	•		•	•				

Voltage vs. Frequency Stability









Reference Frequency: 5825MHz Max. **TEST CONDITIONS** Max. Deviation f fc Deviation (ppm) (MHz) 120 5825.0124 5825 0.0124 2.1254 V nom (V T nom 5825.0683 11.7189 20 132 5825 0.0683 V max (V (°C) 5825.0296 5825 5.0780 V min (V) 108 0.0296 Limits ±20ppm Result Complies

Temperature vs. Frequency Stability

vs. rrec	quency stabl	11 t y						
			Refer	Reference Frequency: 5825MHz				
TEST CONDITIONS				fc	Max. Deviation (MHz)	Max. Deviation (ppm)		
200	T (°C)	0	5825.0072	5825	0.0072	1.2426		
	T (°C)	10	5825.0686	5825	0.0686	11.7750		
120	T (°C)	20	5825.0779	5825	0.0779	13.3768		
	T (°C)	30	5825.0709	5825	0.0709	12.1666		
T (°C) 40				5825	0.0385	6.6037		
Limits				±20ppm				
Re	sult	2	Complies					
	EST CO 120 Lir	T (°C)  120 T (°C)  T (°C)  T (°C)	T (°C) 0 T (°C) 10 T (°C) 20 T (°C) 30 T (°C) 40 Limits	Reference	EST CONDITIONS         f         fc           T (°C)         0         5825.0072         5825           T (°C)         10         5825.0686         5825           120         T (°C)         20         5825.0779         5825           T (°C)         30         5825.0709         5825           T (°C)         40         5825.0385         5825           Limits         ±2	Reference Frequency: 58   Max.   Deviation (MHz)		

# ANT2:

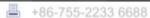
TX Frequency (5150-5250MHz) Voltage vs. Frequency Stability

				Refe	rence Fre	quency: 5	180MHz
\ TI	TEST CONDITIONS				f fc Max. Deviation (ppn		
T nom		V nom (V)	120	5180.0226	5180	0.0226	4.3658
(°C)	20	V max (V)	132	5180.0075	5180	0.0075	1.4496
( 0)	V min (V) 108				5180	0.0913	17.6185
	Li	mits		±20ppm			
	Re	esult			Co	mplies	

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Temperature vs. Frequency Stability

	AVA			Refer	ence Fred	quency: 5	180MHz
Т	EST CO	NDITIONS	6	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
_		T (°C)	0	5180.0913	5180	0.0913	17.6266
V nom 120		T (°C)	10	5180.0452	5180	0.0452	8.7233
		T (°C)	20	5180.0161	5180	0.0161	3.1099
(V)		T (°C)	30	5180.0086	5180	0.0086	1.6601
T (°C) 40				5180.0143	5180	0.0143	2.7697
Limits				±20ppm			
Result				Complies			





				Reference Frequency: 5200MHz			
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
Tnom	T nom 20 V nom (V) 120 V max (V) 132				5200	0.0109	2.0926
(°C)					5200	0.0464	8.9203
( )		V min (V)	108	5200.0740 5200 0.0740 14.2277			
	Li	mits			±2	20ppm	
	R	esult	D2	Complies			

Temperature vs. Frequency Stability

temperature vs. Frequency Stability										
				Refer	Reference Frequency: 5200MHz					
Т	EST CO	NDITIONS	6	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)			
		T (°C)	0	5200.0809	5200	0.0809	15.5493			
V nom		T (°C)	10	5200.0621	5200	0.0621	11.9488			
(V)	120	T (°C)	20	5200.0028	5200	0.0028	0.5458			
( v )		T (°C)	30	5200.0228	5200	0.0228	4.3839			
T (°C) 40				5200.0644	5200	0.0644	12.3889			
Limits					±2	0ppm				
Result				Complies						

Voltage vs. Frequency Stability

+86-400-000-9970











Reference Frequency: 5240MHz Max. **TEST CONDITIONS** Max. Deviation f fc Deviation (ppm) (MHz) 120 5240.0139 5240 V nom (V 0.0139 2.6616 T nom 15.2707 20 132 5240.0800 5240 0.0800 V max (V (°C) 5240.0728 5240 13.8947 V min (V) 108 0.0728 Limits ±20ppm Result Complies

Temperature vs. Frequency Stability

cmpcrature	1100	1	7					
				Refer	Reference Frequency: 5240MHz			
TI	EST CO	NDITIONS	8	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
- 1		T (°C)	0	5240.0276	5240	0.0276	5.2706	
V nom		T (°C)	10	5240.0552	5240	0.0552	10.5387	
	120	T (°C)	20	5240.0842	5240	0.0842	16.0699	
( )	(V) $T (°C)$ 30				5240	0.0386	7.3718	
T (°C) 40				5240.0537	5240	0.0537	10.2476	
	Lir	nits		±20ppm				
	Re	sult	2	Complies				

TX Frequency (5250-5350MHz) Voltage vs. Frequency Stability

Shenzhen ZKT Technology Co., Ltd.















				Deference Fraguency F260MHz			
				Reference Frequency: 5260MHz			
TE	EST CO	ONDITIONS		f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
Tnom	T nom 20 V nom (V) 120 V max (V) 132				5260	0.0240	4.5589
(°C)					5260	0.0897	17.0441
		V min (V)	108	5260.0232	5260	0.0232	4.4085
	Li	mits	·	±20ppm			
	R	esult			Co	omplies	

remperatus	10 15. 110	equency beabl	1101					
				Refer	Reference Frequency: 5260MHz			
TI	EST CO	NDITIONS	6	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
		T (°C)	0	5260.0481	5260	0.0481	9.1454	
V nom		T (°C)	10	5260.0020	5260	0.0020	0.3839	
	120	T (°C)	20	5260.0441	5260	0.0441	8.3780	
(V)		T (°C)	30	5260.0380	5260	0.0380	7.2247	
		T (°C)	40	5260.0521	5260	0.0521	9.9103	
	Lir	nits		±20ppm				
	Re	sult	20	Complies			_	









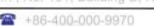


T nom   V nom (V) 120   5280.0493   5280   0.0493   9.3399					Refe	Reference Frequency: 5280MHz			
I nom I '4 '1 '1 '1 '1 '1 '1 '1 '1 '1 '1 '1 '1 '1	TE	EST CC	ONDITIONS		f	fc	Deviation	Max. Deviation (ppm)	
	Tnom	$\frac{1 \text{ nom}}{20}$ $\frac{132}{\text{ max}}$				5280	0.0493	9.3399	
(°C) 20 V max (V) 132 5280.0753 5280 0.0753 14.2597						5280	0.0753	14.2597	
V min (V) 108   5280.0814   5280   0.0814   15.4072	( 0)		V min (V)	108	5280.0814	5280	0.0814	15.4072	
Limits ±20ppm	0	Li	mits			±2	20ppm		
Result Complies		Re	esult	52	Complies				

Temperature vs. Frequency Stability

T C III P C T a C u I	emperature vs. Frequency Stability										
				Reference Frequency: 5280MHz							
TI	EST CO	NDITIONS	3	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)				
		T (°C)	0	5280.0102	5280	0.0102	1.9375				
V nom		T (°C)	10	5280.0913	5280	0.0913	17.2833				
(V)	120	T (°C)	20	5280.0113	5280	0.0113	2.1460				
( <b>v</b> )		T (°C)	30	5280.0053	5280	0.0053	1.0099				
		T (°C)	40	5280.0353	5280	0.0353	6.6890				
	Lir	nits	2	±20ppm							
	Re	sult	7	Complies							

Voltage vs. Frequency Stability



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Reference Frequency: 5320MHz Max. **TEST CONDITIONS** Max. Deviation f fc Deviation (ppm) (MHz) 120 5320.0074 5320 1.3902 V nom (V 0.0074 T nom 5320.0692 20 132 5320 0.0692 13.0112 V max (V (°C) 108 5320.0525 5320 9.8712 V min (V) 0.0525 Limits ±20ppm Result Complies

Temperature vs. Frequency Stability

cmpcrature	vs. 1100	quency Stabi	iity					
				Refer	rence Fred	quency: 5	320MHz	
T	EST CO	NDITIONS	8	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
- 1		T (°C)	-20	5320.0871	5320	0.0871	16.3718	
		T (°C)	-10	5320.0132	5320	0.0132	2.4854	
		T (°C)	0	5320.0358	5320	0.0358	6.7376	
		T (°C)	10	5320.0328	5320	0.0328	6.1636	
V nom	120	T (°C)	20	5320.0585	5320	0.0585	10.9882	
(V)	120	T (°C)	30	5320.0206	5320	0.0206	3.8631	
		T (°C)	40	5320.0925	5320	0.0925	17.3939	
		T (°C)	50	5320.0386	5320	0.0386	7.2577	
	T (°C) 6			5320.0154	5320	0.0154	2.8998	
T (°C) 70				5320.0777	5320	0.0777	14.6014	
	Lir	nits			±2	20ppm		
100	Re	sult			Со	mplies		

TX Frequency (5470-5725MHz)
Voltage vs. Frequency Stability

















				Reference Frequency: 5500MHz				
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)	
Tnom	T nom 20 V nom (V) 120 V max (V) 132				5500	0.0925	16.8215	
(°C)					5500	0.0322	5.8476	
		V min (V)	108	5500.0242 5500 0.0242 4.3943				
	Li	mits			±2	20ppm		
1	R	esult		Complies				

# Temperature vs. Frequency Stability

remperatus	10 15. 110	equency beabl					
				Reference Frequency: 5500MHz			
Т	EST CO	NDITIONS	8	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
		T (°C)	0	5500.0599	5500	0.0599	10.8865
V nom		T (°C)	10	5500.0017	5500	0.0017	0.3150
(V)	120	T (°C)	20	5500.0533	5500	0.0533	9.6903
( V )		T (°C)	30	5500.0900	5500	0.0900	16.3721
		T (°C)	40	5500.0809	5500	0.0809	14.7088
	Lir	nits		±20ppm			
	Re	sult	20	Complies			











				Reference Frequency: 5580MHz			
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
Tnom	T nom 20 V nom (V) 120 V max (V) 132				5580	0.0246	4.4116
					5580	0.0228	4.0831
(°C) V min (V) 108				5580.0864	5580	0.0864	15.4920
0	Li	mits		_	±2	20ppm	
	R	esult	b))	Complies			

Temperature vs. Frequency Stability

			•	D (			
				Reference Frequency: 5580MHz			
ТІ	EST CO	NDITIONS	6	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
	G	T (°C)	0	5580.0685	5580	0.0685	12.2683
V nom		T (°C)	10	5580.0883	5580	0.0883	15.8200
(V)	120	T (°C)	20	5580.0545	5580	0.0545	9.7727
( <b>v</b> )		T (°C)	30	5580.0448	5580	0.0448	8.0337
	T (°C) 40				5580	0.0405	7.2586
Limits			±20ppm				
Result				Complies			

Voltage vs. Frequency Stability

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Reference Frequency: 5700MHz Max. **TEST CONDITIONS** Max. Deviation f fc Deviation (ppm) (MHz) 120 5700.0824 5700 14.4484 V nom (V 0.0824 T nom 5700.0719 5700 20 132 0.0719 12.6060 V max (V (°C) 108 5700.0171 5700 3.0079 V min (V) 0.0171 Limits ±20ppm Result Complies

remperature	7 75. 1100	quency beabl	1101				
				Reference Frequency: 5700MHz			
Т	EST CO	NDITIONS	3	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
		T (°C)	0	5700.0857	5700	0.0857	15.0267
V nom		T (°C)	10	5700.0023	5700	0.0023	0.4098
	120	T (°C)	20	5700.0108	5700	0.0108	1.9034
(V)		T (°C)	30	5700.0018	5700	0.0018	0.3155
		T (°C)	40	5700.0096	5700	0.0096	1.6814
	Limits			±20ppm			
	Result			Complies			











TX Frequency (5725-5850MHz) Voltage vs. Frequency Stability

				Reference Frequency: 5745MHz				
TEST CONDITIONS			f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)		
T nom		V nom (V)	120	5745.0188	5745	0.0188	3.2781	
(°C)	20	V max (V)	132	5745.0849	5745	0.0849	14.7736	
( 0)		V min (V)	108	5745.0543	5745	0.0543	9.4551	
	Limits			±20ppm				
Result			Complies					

# Temperature vs. Frequency Stability

	60			Refer	ence Fred	quency: 5	745MHz
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
		T (°C)	0	5745.0123	5745	0.0123	2.1370
V nom		T (°C)	10	5745.0905	5745	0.0905	15.7551
(V)	120	T (°C)	20	5745.0166	5745	0.0166	2.8868
( v )		T (°C)	30	5745.0087	5745	0.0087	1.5147
	T (°C) 40				5745	0.0834	14.5164
	Limits			±20ppm			
	Result				Со	mplies	











				Reference Frequency: 5785MHz							
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)				
T nom	10	V nom (V)	120	5785.0876	5785	0.0876	15.1416				
	20	20	20	20	'' 20	V max (V)	132	5785.0442	5785	0.0442	7.6373
( 0)	(°C) V min (V) 108				5785	0.0760	13.1307				
	Limits			±20ppm							
Result			Complies								

Temperature vs. Frequency Stability

Tomp of a car.	emperature vs. Frequency Stability								
				Refer	Reference Frequency: 5785MHz				
Т	EST CO	NDITIONS	6	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)		
		T (°C)	0	5785.0609	5785	0.0609	10.5269		
		T (°C)	10	5785.0464	5785	0.0464	8.0157		
V nom	120	T (°C)	20	5785.0897	5785	0.0897	15.5071		
(V)	120	T (°C)	30	5785.0810	5785	0.0810	14.0004		
		T (°C)	40	5785.0642	5785	0.0642	11.1037		
	T (°C) 50				5785	0.0904	15.6217		
Limits			±20ppm						
Result			Complies			_			

Voltage vs. Frequency Stability

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				Reference Frequency: 5825MHz						
TEST CONDITIONS				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)			
T nom	747	V nom (V)	120	5825.0765	5825	0.0765	13.1285			
	20	20	20	1 20	V max (V)	132	5825.0761	5825	0.0761	13.0655
( )	(°C) V min (V) 108				5825	0.0920	15.7993			
	Limits				±20ppm					
1	Result				Complies					

## Temperature vs. Frequency Stability

remperature	18. 1100	quency beabl	1101				
				Reference Frequency: 5825MHz			
Т	EST CO	NDITIONS	8	f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
	200	T (°C)	0	5825.0666	5825	0.0666	11.4263
V nom		T (°C)	10	5825.0024	5825	0.0024	0.4107
(V)	120	T (°C)	20	5825.0127	5825	0.0127	2.1749
( )		T (°C)	30	5825.0760	5825	0.0760	13.0461
		T (°C)	40	5825.0496	5825	0.0496	8.5145
	Limits			±20ppm			
	Result			Complies			











## 2. OPERATION IN THE ABSENCE OF INFORMATION TO THE TRANSMIT

## 13.1 Requirement

#### 15.407(c) requirement:

The device shall automatically discontinue transmission in case of either absence of information to transmit or operational failure. These provisions are not intended to preclude the transmission of control or signal ling information or the use of repetitive codes used by certain digital technologies to complete frame or burst intervals. Applicants shall include in their application for equipment authorization a description of how this requirement is met.

#### 13.2 Test Results

Operation in the absence of information to the transmit:

While the EUT is not transmitting any information, the EUT can automatically discontinue transmission and become standby mode for power saving. The EUT can detect the controlling signal of ASK message transmitting from remote device and verify whether it shall resend or discontinue transmission. (manufacturer declare )

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### 3. DUTY CYCLE

#### 14.1 Applied procedures / limit

Measurements of duty cycle and transmission duration shall be performed using one of the following techniques:

- A diode detector and an oscilloscope that together have a sufficiently short response time to permit accurate measurements of the ON and OFF times of the transmitted signal.
- b) The zero-span mode on a spectrum analyzer or EMI receiver if the response time and spacing between bins on the sweep are sufficient to permit accurate measurements of the ON and OFF times of the transmitted signal:
  - Set the center frequency of the instrument to the center frequency of the transmission.
  - 2) Set RBW ≥ OBW if possible; otherwise, set RBW to the largest available value.
  - Set VBW ≥ RBW. Set detector = peak or average.
  - 4) The zero-span measurement method shall not be used unless both RBW and VBW are > 50/T and the number of sweep points across duration T exceeds 100. (For example, if VBW and/or RBW are limited to 3 MHz, then the zero-span method of measuring the duty cycle shall not be used if T≤ 16.7 μs.)

#### 14.2 DEVIATION FROM STANDARD

No deviation.

#### 14.3 TEST SETUP

EUT	SPECTRUM
\$4.00000000000 X	ANALYZER

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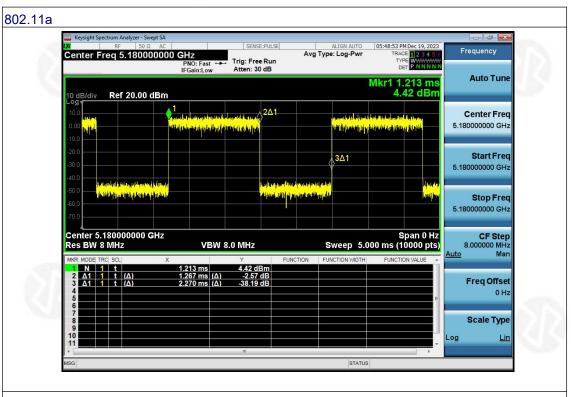




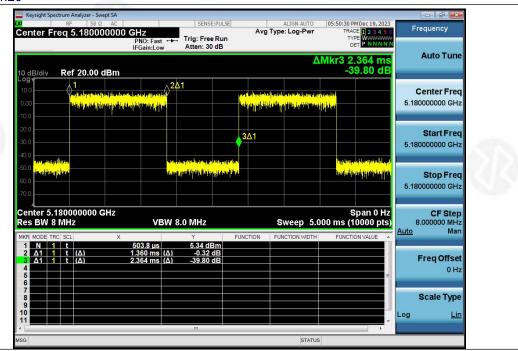


	5.2G								
Mode	Frequency (MHz)	Duty Cycle (%)	Duty Cycle Correction Factor (dB)	Result					
802.11a	5180	55.81	2.53	Pass					
802.11n20	5180	57.53	2.40	Pass					
802.11n40	5190	38.52	4.14	Pass					
802.11ac20	5180	55.92	2.52	Pass					
802.11ac40	5190	38.78	4.11	Pass					
802.11ac80	5210	23.92	6.21	Pass					





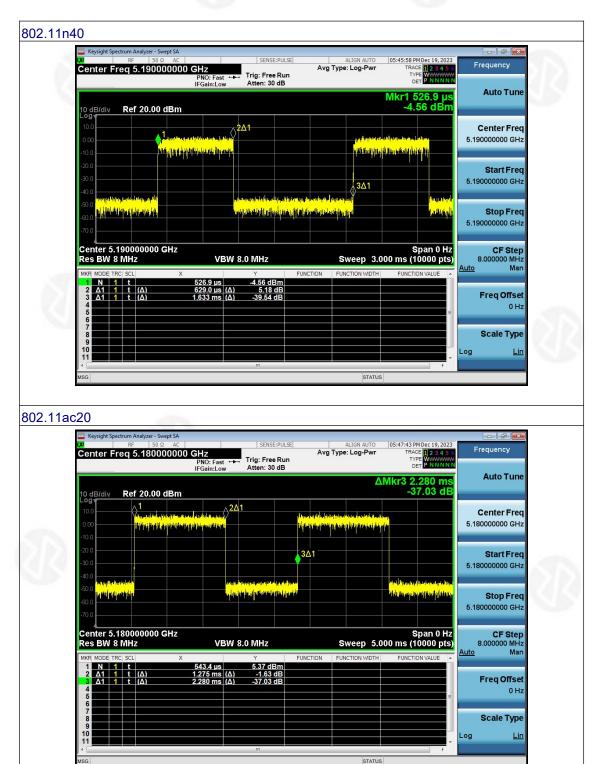




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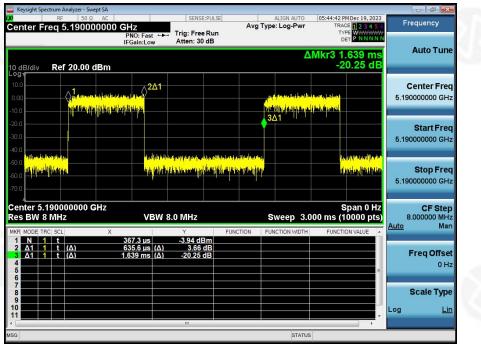
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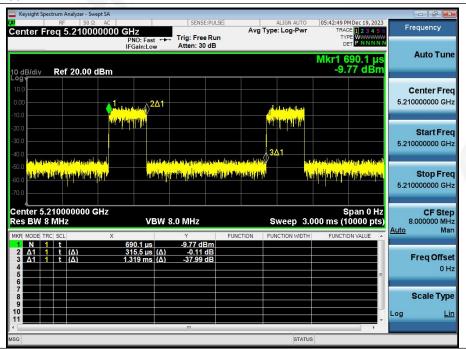








## 802.11ac80



Note: All channel have been tested, and the report only reflects the worst case data.

Duty Cycle= Ton /Total\*100%

Duty Cycle Correction Factor = 10log (1/Duty Cycle)

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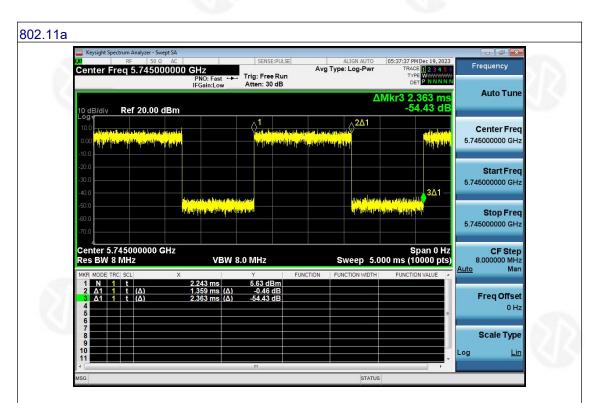




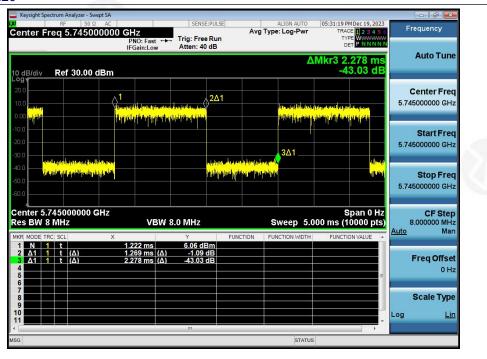


	5.8G							
Mode	Frequency (MHz)	Duty Cycle (%)	Duty Cycle Correction Factor (dB)	Result				
802.11a	5745	57.51	2.40	Pass				
802.11n20	5745	55.71	2.54	Pass				
802.11n40	5755	38.64	4.13	Pass				
802.11ac20	5745	55.87	2.53	Pass				
802.11ac40	5755	38.79	4.11	Pass				
802.11ac80	5775	23.85	6.23	Pass				







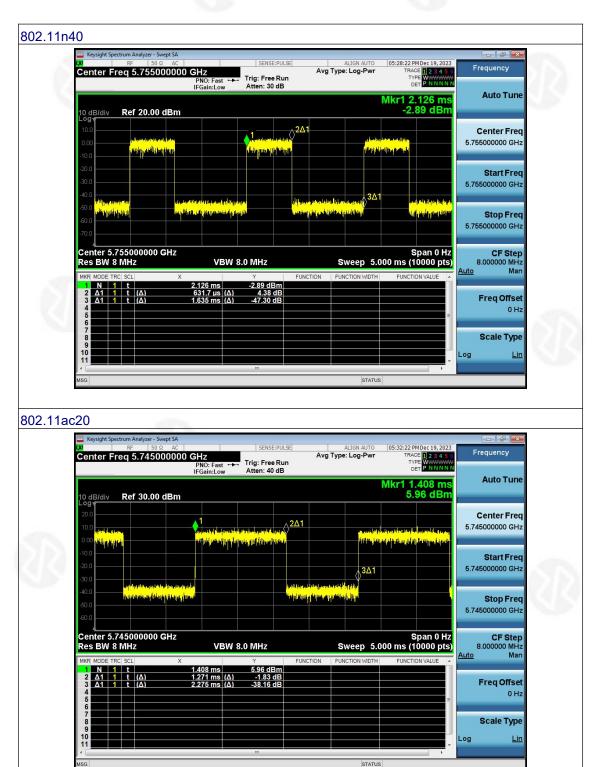


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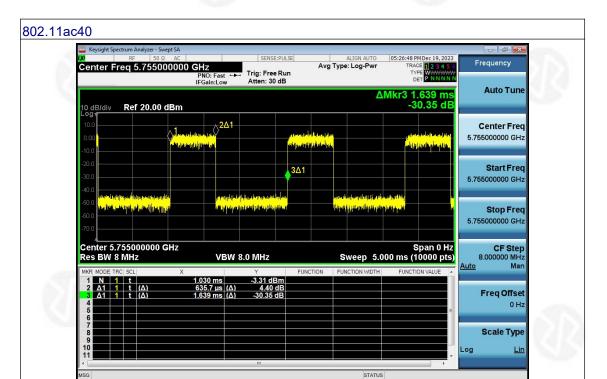




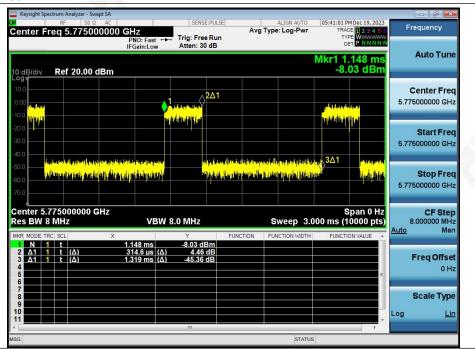
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Note: All channel have been tested, and the report only reflects the worst case data.

Duty Cycle= Ton /Total\*100%

Duty Cycle Correction Factor = 10log (1/Duty Cycle)

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#### 4. ANTENNA REQUIREMENT

#### 15.203 requirement:

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. 15.247(b) (4) requirement:

The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

# **EUT Antenna:**

The antenna is External Antenna and no consideration of replacement. The best case gain of the antenna is 2.0 dBi.

\*\*\*\* END OF REPORT \*\*\*\*











